

Seongjae Cho

List of Publications by Year in descending order

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144
papers

1,590
citations

331259

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144
all docs

144
docs citations

144
times ranked

1159
citing authors

#	ARTICLE	IF	CITATIONS
1	Optimization of the structural complexity of artificial neural network for hardware-driven neuromorphic computing application. <i>Applied Intelligence</i> , 2023, 53, 6288-6306.	3.3	11
2	Novel Au nanorod/Cu ₂ O composite nanoparticles for a high-performance supercapacitor. <i>RSC Advances</i> , 2022, 12, 9112-9120.	1.7	4
3	Emulation of synaptic functions with low voltage organic memtransistor for hardware oriented neuromorphic computing. <i>Scientific Reports</i> , 2022, 12, 3808.	1.6	23
4	Optimization of Feedback FET with Asymmetric Source Drain Doping Profile. <i>Micromachines</i> , 2022, 13, 508.	1.4	2
5	Medium-Temperature-Oxidized GeOx Resistive-Switching Random-Access Memory and Its Applicability in Processing-in-Memory Computing. <i>Nanoscale Research Letters</i> , 2022, 17, .	3.1	10
6	Key factors affecting contact resistance in coplanar organic thin-film transistors. <i>Journal Physics D: Applied Physics</i> , 2022, 55, 405101.	1.3	7
7	Recent Advances in Electrical Doping of 2D Semiconductor Materials: Methods, Analyses, and Applications. <i>Nanomaterials</i> , 2021, 11, 832.	1.9	36
8	Performance Improvement of 1T DRAM by Raised Source and Drain Engineering. <i>IEEE Transactions on Electron Devices</i> , 2021, 68, 1577-1584.	1.6	16
9	Nanoscale wedge resistive-switching synaptic device and experimental verification of vector-matrix multiplication for hardware neuromorphic application. <i>Japanese Journal of Applied Physics</i> , 2021, 60, 050905.	0.8	9
10	Process Steps for High Quality Si-Based Epitaxial Growth at Low Temperature via RPCVD. <i>Materials</i> , 2021, 14, 3733.	1.3	2
11	Density functional theory study on the modification of silicon nitride surface by fluorine-containing molecules. <i>Applied Surface Science</i> , 2021, 554, 149481.	3.1	5
12	Core-Shell Dual-Gate Nanowire Charge-Trap Memory for Synaptic Operations for Neuromorphic Applications. <i>Nanomaterials</i> , 2021, 11, 1773.	1.9	15
13	A More Hardware-Oriented Spiking Neural Network Based on Leading Memory Technology and Its Application With Reinforcement Learning. <i>IEEE Transactions on Electron Devices</i> , 2021, 68, 4411-4417.	1.6	13
14	Reliability improvement of 1T DRAM based on feedback transistor by using local partial insulators. <i>Japanese Journal of Applied Physics</i> , 2021, 60, 104002.	0.8	2
15	Improvement of Resistive Switching Characteristics of Titanium Oxide Based Nanowedge RRAM Through Nickel Silicidation. <i>IEEE Transactions on Electron Devices</i> , 2021, 68, 438-442.	1.6	5
16	Threshold-Variation-Tolerant Coupling-Gate \pm IGZO Synaptic Transistor for More Reliably Controllable Hardware Neuromorphic System. <i>IEEE Access</i> , 2021, 9, 59345-59352.	2.6	10
17	Core-Shell Dual-Gate Nanowire Memory as a Synaptic Device for Neuromorphic Application. <i>IEEE Journal of the Electron Devices Society</i> , 2021, 9, 1282-1289.	1.2	11
18	Analytically and empirically consistent characterization of the resistive switching mechanism in a Ag conducting-bridge random-access memory device through a pseudo-liquid interpretation approach. <i>Physical Chemistry Chemical Physics</i> , 2021, 23, 27234-27243.	1.3	1

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19	More physical understanding of current characteristics of tunneling field-effect transistor leveraged by gate positions and properties through dual-gate and gate-all-around structuring. Applied Physics A: Materials Science and Processing, 2020, 126, 1.	1.1	2
20	Zinc Tin Oxide Synaptic Device for Neuromorphic Engineering. IEEE Access, 2020, 8, 130678-130686.	2.6	41
21	A highly reliable physics-based SPICE compact model of IGZO memristor considering the dependence on electrode metals and deposition sequence. Solid-State Electronics, 2020, 166, 107764.	0.8	5
22	A Novel 1T DRAM with Shell/Core Dual-Gate Architecture. , 2020, , .		1
23	A Quantum-Well Charge-Trap Synaptic Transistor With Highly Linear Weight Tunability. IEEE Journal of the Electron Devices Society, 2020, 8, 834-840.	1.2	9
24	Multilevel Switching Characteristics of Si ₃ N ₄ -Based Nano-Wedge Resistive Switching Memory and Array Simulation for In-Memory Computing Application. Electronics (Switzerland), 2020, 9, 1228.	1.8	5
25	Pd/IGZO/p ⁺ -Si Synaptic Device with Self-Graded Oxygen Concentrations for Highly Linear Weight Adjustability and Improved Energy Efficiency. ACS Applied Electronic Materials, 2020, 2, 2390-2397.	2.0	17
26	Design and Analysis of Core-Gate Shell-Chanel 1T DRAM. , 2020, , .		0
27	Fabrication and Characterization of TiO _x Memristor for Synaptic Device Application. IEEE Nanotechnology Magazine, 2020, 19, 475-480.	1.1	19
28	Bipolar resistive switching with unidirectional selector function in nitride/oxide heterostructures. Journal Physics D: Applied Physics, 2020, 53, 435102.	1.3	13
29	Investigation of the Thermal Recovery From Reset Breakdown of a SiN _x -Based RRAM. IEEE Transactions on Electron Devices, 2020, 67, 1600-1605.	1.6	10
30	Double-Gate Junctionless 1T DRAM With Physical Barriers for Retention Improvement. IEEE Transactions on Electron Devices, 2020, 67, 1471-1479.	1.6	22
31	Analysis of the Sensing Margin of Silicon and Poly-Si 1T-DRAM. Micromachines, 2020, 11, 228.	1.4	10
32	HfO _x -based nano-wedge structured resistive switching memory device operating at sub-1/4A current for neuromorphic computing application. Semiconductor Science and Technology, 2020, 35, 055002.	1.0	2
33	Insertion of Ag Layer in TiN/SiN _x /TiN RRAM and Its Effect on Filament Formation Modeled by Monte Carlo Simulation. IEEE Access, 2020, 8, 228720-228730.	2.6	7
34	Investigation of Modified 1T DRAM with Twin Gate Tunneling Field Effect Transistor for Improved Retention Characteristics. Journal of Semiconductor Technology and Science, 2020, 20, 145-150.	0.1	6
35	Charge Based Current-Voltage Model for the Silicon on Insulator Junctionless Field-Effect Transistor. Journal of Nanoscience and Nanotechnology, 2020, 20, 4920-4925.	0.9	0
36	Dependency of electrical performances and reliability of 28 nm logic transistor on gate oxide interface treatment methods. Applied Physics Express, 2020, 13, 101003.	1.1	0

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37	Analysis of operation characteristics of junctionless poly-Si 1T-DRAM in accumulation mode. Semiconductor Science and Technology, 2019, 34, 105007.	1.0	6
38	Improved Gradual Reset Phenomenon in SiNx-based RRAM by Diode-Connected Structure. , 2019, , .		0
39	Ultrasensitive MoS2 photodetector by serial nano-bridge multi-heterojunction. Nature Communications, 2019, 10, 4701.	5.8	66
40	Comparison of switching characteristics of HfO _x RRAM device with different switching layer thicknesses. , 2019, , .		0
41	A polycrystalline-silicon dual-gate MOSFET-based 1T-DRAM using grain boundary-induced variable resistance. Applied Physics Letters, 2019, 114, .	1.5	20
42	Design Optimization and Analysis of InGaAs/InAs/InGaAs Heterojunction-Based Electron Hole Bilayer Tunneling FETs. Journal of Nanoscience and Nanotechnology, 2019, 19, 6070-6076.	0.9	4
43	A Band-Engineered One-Transistor DRAM With Improved Data Retention and Power Efficiency. IEEE Electron Device Letters, 2019, 40, 562-565.	2.2	14
44	Fabrication and Characterization of a Thin-Body Poly-Si 1T DRAM With Charge-Trap Effect. IEEE Electron Device Letters, 2019, 40, 566-569.	2.2	27
45	Synaptic behaviors of HfO ₂ ReRAM by pulse frequency modulation. Solid-State Electronics, 2019, 154, 31-35.	0.8	11
46	Design and analysis of logic inverter using antimonide-based compound semiconductor junctionless transistor. Applied Physics A: Materials Science and Processing, 2019, 125, 1.	1.1	2
47	Si _{1-x} Ge _x /SiGe shell channel nanowire FET for sub-10nm logic technology in the THz regime. ETRI Journal, 2019, 41, 829-837.	1.2	1
48	Ni/GeOx/p+ Si resistive-switching random-access memory with full Si processing compatibility and its characterization and modeling. Vacuum, 2019, 161, 63-70.	1.6	4
49	Microwave analysis of SiGe heterojunction double-gate tunneling field-effect transistor through its small-signal equivalent circuit. International Journal of RF and Microwave Computer-Aided Engineering, 2019, 29, e21678.	0.8	2
50	Design and Characterization of Semi-Floating-Gate Synaptic Transistor. Micromachines, 2019, 10, 32.	1.4	12
51	Investigation and Optimization of Double-gate MPI 1T DRAM with Gate-induced Drain Leakage Operation. Journal of Semiconductor Technology and Science, 2019, 19, 165-171.	0.1	5
52	A More Accurate Analytical DC Compact Modeling of Tunneling Field-Effect Transistor for SPICE Simulation. Journal of Semiconductor Technology and Science, 2019, 19, 551-560.	0.1	1
53	SiGe Heterojunction FinFET Towards Tera-Hertz Applications. Journal of the Korean Physical Society, 2018, 72, 527-532.	0.3	0
54	Scaling Effect on Silicon Nitride Memristor with Highly Doped Si Substrate. Small, 2018, 14, e1704062.	5.2	74

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55	Design and Electrical Characterization of 2-T Thyristor RAM With Low Power Consumption. IEEE Electron Device Letters, 2018, 39, 355-358.	2.2	10
56	Ultrathin SiGe Shell Channel p-Type FinFET on Bulk Si for Sub-10-nm Technology Nodes. IEEE Transactions on Electron Devices, 2018, 65, 1290-1297.	1.6	19
57	Circuit-level simulation of resistive-switching random-access memory cross-point array based on a highly reliable compact model. Journal of Computational Electronics, 2018, 17, 273-278.	1.3	3
58	Simulation of One-Transistor Dynamic Random-Access Memory Based on Symmetric Double-Gate Si Junctionless Transistor. Journal of Nanoscience and Nanotechnology, 2018, 18, 6593-6597.	0.9	0
59	A Novel One-Transistor Dynamic Random-Access Memory (1T DRAM) Featuring Partially Inserted Wide-Bandgap Double Barriers for High-Temperature Applications. Micromachines, 2018, 9, 581.	1.4	9
60	Analysis of SiGe Heterojunction Tunneling Field-Effect Transistor in the Microwave Regime Through Its Small-Signal Equivalent Circuit. , 2018, , .		0
61	A Highly Scalable and Energy-Efficient 1T DRAM Embedding a SiGe Quantum Well Structure for Significant Retention Enhancement. , 2018, , .		2
62	Gradual switching and self-rectifying characteristics of Cu/±-IGZO/p+-Si RRAM for synaptic device application. Solid-State Electronics, 2018, 150, 60-65.	0.8	23
63	Integrate-and-fire neuron circuit using positive feedback field effect transistor for low power operation. Journal of Applied Physics, 2018, 124, .	1.1	33
64	Analysis of tunneling field-effect transistor with germanium source junction using small-signal equivalent circuit. Microwave and Optical Technology Letters, 2018, 60, 2922-2927.	0.9	1
65	Characterization and Optimization of Inverted-T FinFET Under Nanoscale Dimensions. IEEE Transactions on Electron Devices, 2018, 65, 3521-3527.	1.6	34
66	Fabrication and Characterization of a Fully Si Compatible Forming-Free GeO _x Resistive Switching Random-Access Memory. , 2018, , .		0
67	Uniformity Improvement of SiN _x -Based Resistive Switching Memory by Suppressed Internal Overshoot Current. IEEE Nanotechnology Magazine, 2018, 17, 824-828.	1.1	20
68	Processing and Characterization of Ultra-thin Poly-crystalline Silicon for Memory and Logic Applications. Journal of Semiconductor Technology and Science, 2018, 18, 172-179.	0.1	6
69	Nano-cone resistive memory for ultralow power operation. Nanotechnology, 2017, 28, 125207.	1.3	27
70	Pulse area dependent gradual resistance switching characteristics of CMOS compatible SiN _x -based resistive memory. Solid-State Electronics, 2017, 132, 109-114.	0.8	11
71	An accurate simulation study on capacitance-voltage characteristics of metal-oxide-semiconductor field-effect transistors in novel structures. Physica B: Condensed Matter, 2017, 521, 305-311.	1.3	2
72	Dual gate positive feedback field-effect transistor for low power analog circuit. , 2017, , .		4

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73	Effects of nitride trap layer properties on location of charge centroid in charge-trap flash memory. , 2017, , .		0
74	Uniformity improvement of SiN _j c-based resistive switching memory by suppressed internal overshoot current. , 2017, , .		0
75	Electrical Performances of InN/GaN Tunneling Field-Effect Transistor. Journal of Nanoscience and Nanotechnology, 2017, 17, 8355-8359.	0.9	1
76	Design and Analysis for 3D Vertical Resistive Random Access Memory Structures with Silicon Bottom Electrodes. Journal of Nanoscience and Nanotechnology, 2017, 17, 7160-7163.	0.9	0
77	Bias Polarity Dependent Resistive Switching Behaviors in Silicon Nitride-Based Memory Cell. IEICE Transactions on Electronics, 2016, E99.C, 547-550.	0.3	3
78	Fully Si compatible SiN resistive switching memory with large self-rectification ratio. AIP Advances, 2016, 6, .	0.6	33
79	Improved resistive switching properties in SiO _x -based resistive random-access memory cell with Ti buffer layer. Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics, 2016, 34, .	0.6	5
80	Design of Poly-Si Junctionless Fin-Channel FET With Quantum-Mechanical Drift-Diffusion Models for Sub-10-nm Technology Nodes. IEEE Transactions on Electron Devices, 2016, 63, 4610-4616.	1.6	23
81	Sub-10 nm Ge/GaAs Heterojunction-Based Tunneling Field-Effect Transistor with Vertical Tunneling Operation for Ultra-Low-Power Applications. Journal of Semiconductor Technology and Science, 2016, 16, 172-178.	0.1	5
82	Simulation Study on Silicon-Based Floating Body Synaptic Transistor with Short- and Long-Term Memory Functions and Its Spike Timing-Dependent Plasticity. Journal of Semiconductor Technology and Science, 2016, 16, 657-663.	0.1	15
83	Design and analysis of nanowire p-type MOSFET coaxially having silicon core and germanium peripheral channel. Japanese Journal of Applied Physics, 2016, 55, 114001.	0.8	8
84	Si CMOS Extension and Ge Technology Perspectives Forecast Through Metal-oxide-semiconductor Junctionless Field-effect Transistor. Journal of Semiconductor Technology and Science, 2016, 16, 847-853.	0.1	2
85	Effects of conducting defects on resistive switching characteristics of SiN _x -based resistive random-access memory with MIS structure. Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics, 2015, 33, .	0.6	28
86	Resistive Switching Characteristics of Silicon Nitride-Based RRAM Depending on Top Electrode Metals. IEICE Transactions on Electronics, 2015, E98.C, 429-433.	0.3	17
87	A study on room-temperature photoluminescence and crystallinity of RF-sputtered GaN for a cost-effective III-V-on-Si platform. Journal of the Korean Physical Society, 2015, 67, 1838-1843.	0.3	1
88	Analyses on RF Performances of Silicon-Compatible InGaAs-Based Planar-Type and Fin-Type Junctionless Field-Effect Transistors. Journal of Nanoscience and Nanotechnology, 2015, 15, 7615-7619.	0.9	2
89	High-performance Ge/GaAs heterojunction tunneling FET with a channel engineering for sub-0.5 V operation. Semiconductor Science and Technology, 2015, 30, 035020.	1.0	3
90	Resistive switching characteristics of Si ₃ N ₄ -based resistive-switching random-access memory cell with tunnel barrier for high density integration and low-power applications. Applied Physics Letters, 2015, 106, .	1.5	77

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91	Ge-on-Si photodetector with novel metallization schemes for on-chip optical interconnect. , 2015, , .		0
92	Gradual bipolar resistive switching in Ni/Si ₃ N ₄ /n+-Si resistive-switching memory device for high-density integration and low-power applications. Solid-State Electronics, 2015, 114, 94-97.	0.8	26
93	Design and analysis of Si-based arch-shaped gate-all-around (GAA) tunneling field-effect transistor (TFET). Current Applied Physics, 2015, 15, 208-212.	1.1	24
94	Design of a recessed-gate GaN-based MOSFET using a dual gate dielectric for high-power applications. Journal of the Korean Physical Society, 2014, 65, 1579-1584.	0.3	2
95	O<inf>2</inf>-Enhanced surface treatment of Ge epitaxially grown on Si for heterogeneous Ge technology. , 2014, , .		0
96	Optimization and modeling of npn-type selector for resistive RRAM in cross-point array structure. , 2014, , .		0
97	Switching and conduction mechanism of Cu/Si ₃ N ₄ /Si RRAM with CMOS compatibility. , 2014, , .		2
98	Fabrication and Characterization of GaN-based Light-emitting Diode (LED) with Triangle-type Structure. Molecular Crystals and Liquid Crystals, 2014, 599, 163-169.	0.4	1
99	Analyses on ZnO/CdS heterojunction for design of CIGS photovoltaic device with higher accuracy. , 2014, , .		0
100	Analysis of Radio Frequency Performance on GaAs/InGaAs Heterojunction Tunneling Field-Effect Transistor which Applicable for Green Energy System Applications. , 2014, , .		2
101	Dependence of device performances on fin dimensions in AlGaIn/GaN recessed-gate nanoscale FinFET. , 2014, , .		1
102	Vertical stack array of one-time programmable nonvolatile memory based on pn-junction diode and its operation scheme for faster access. IEICE Electronics Express, 2014, 11, 20131041-20131041.	0.3	0
103	Heteromaterial Gate Tunneling Field-Effect Transistor for High-Speed and Radio-Frequency Applications. Journal of Nanoscience and Nanotechnology, 2014, 14, 8136-8140.	0.9	3
104	Design and Analysis of Sub-10 nm Junctionless Fin-Shaped Field-Effect Transistors. Journal of Semiconductor Technology and Science, 2014, 14, 508-517.	0.1	16
105	More Accurate and Reliable Extraction of Tunneling Resistance in Tunneling FET and Verification in Small-Signal Circuit Operation. IEEE Transactions on Electron Devices, 2013, 60, 3318-3324.	1.6	12
106	InGaAs/InP heterojunction-channel tunneling field-effect transistor for ultra-low operating and standby power application below supply voltage of 0.5V. Current Applied Physics, 2013, 13, 2051-2054.	1.1	9
107	Simulation study on effect of drain underlap in gate-all-around tunneling field-effect transistors. Current Applied Physics, 2013, 13, 1143-1149.	1.1	40
108	Mixed-Mode Simulation of Nanowire Ge/GaAs Heterojunction Tunneling Field-Effect Transistor for Circuit Applications. IEEE Journal of the Electron Devices Society, 2013, 1, 48-53.	1.2	9

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109	Silicon-compatible high-hole-mobility transistor with an undoped germanium channel for low-power application. Applied Physics Letters, 2013, 103, 222102.	1.5	7
110	Room-temperature electroluminescence from germanium in an Al _{0.3} Ga _{0.7} As/Ge heterojunction light-emitting diode by Γ^c -valley transport. Optics Express, 2012, 20, 14921.	1.7	13
111	Stacked Gated Twin-Bit (SGTB) SONOS Memory Device for High-Density Flash Memory. IEEE Nanotechnology Magazine, 2012, 11, 307-313.	1.1	4
112	Simulation study on scaling limit of silicon tunneling field-effect transistor under tunneling-predominance. IEICE Electronics Express, 2012, 9, 828-833.	0.3	2
113	Simulation study on process conditions for high-speed silicon photodetector and quantum-well structuring for increased number of wavelength discriminations. , 2012, , .		0
114	Design optimization of tunneling field-effect transistor based on silicon nanowire PNPN structure and its radio frequency characteristics. Current Applied Physics, 2012, 12, 673-677.	1.1	22
115	Silicon-compatible bulk-type compound junctionless field-effect transistor. , 2011, , .		8
116	Fabrication and Analysis of Epitaxially Grown Ge _{1-x} Sn _x Microdisk Resonator With 20-nm Free-Spectral Range. IEEE Photonics Technology Letters, 2011, 23, 1535-1537.	1.3	12
117	Silicon-compatible compound semiconductor tunneling field-effect transistor for high performance and low standby power operation. Applied Physics Letters, 2011, 99, .	1.5	36
118	A New 1T DRAM Cell: Cone Type 1T DRAM Cell. IEICE Transactions on Electronics, 2011, E94-C, 681-685.	0.3	0
119	RF Performance and Small-Signal Parameter Extraction of Junctionless Silicon Nanowire MOSFETs. IEEE Transactions on Electron Devices, 2011, 58, 1388-1396.	1.6	170
120	DIBL-Induced Program Disturb Characteristics in 32-nm NAND Flash Memory Array. IEEE Transactions on Electron Devices, 2011, 58, 3626-3629.	1.6	8
121	Analyses on Small-Signal Parameters and Radio-Frequency Modeling of Gate-All-Around Tunneling Field-Effect Transistors. IEEE Transactions on Electron Devices, 2011, 58, 4164-4171.	1.6	82
122	Compact modeling of silicon nanowire MOSFET for radio frequency applications. Microwave and Optical Technology Letters, 2011, 53, 471-473.	0.9	2
123	Investigation of source-to-drain capacitance by DIBL effect of silicon nanowire MOSFETs. IEICE Electronics Express, 2010, 7, 1499-1503.	0.3	3
124	Highly scalable vertical bandgap-engineered NAND flash memory. , 2010, , .		0
125	A Vertical 4-Bit SONOS Flash Memory and a Unique 3-D Vertical nor Array Structure. IEEE Nanotechnology Magazine, 2010, 9, 70-77.	1.1	10
126	Simulation of Gate-All-Around Tunnel Field-Effect Transistor with an n-Doped Layer. IEICE Transactions on Electronics, 2010, E93-C, 540-545.	0.3	11

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127	Simulation Study on Dependence of Channel Potential Self-Boosting on Device Scale and Doping Concentration in 2-D and 3-D NAND-Type Flash Memory Devices. IEICE Transactions on Electronics, 2010, E93-C, 596-601.	0.3	0
128	Enhancement of erase speed using silicide drain in nanowire SONOS NAND flash memory. , 2009, , .		0
129	A 2-Bit Recessed Channel Nonvolatile Memory Device With a Lifted Charge-Trapping Node. IEEE Nanotechnology Magazine, 2009, 8, 111-115.	1.1	3
130	Channel doping concentration and fin width effects on self-boosting in NAND-type SONOS flash memory array based on bulk-FinFETs. , 2009, , .		3
131	Design of SOI FinFET on 32 nm technology node for low standby power (LSTP) operation considering gate-induced drain leakage (GIDL). , 2009, , .		0
132	Dependence of program and erase speed on bias conditions for fully depleted channel of vertical NAND flash memory devices. , 2009, , .		0
133	Recessed Channel Dual Gate Single Electron Transistors (RCDG-SETs) for Room Temperature Operation. IEICE Transactions on Electronics, 2009, E92-C, 647-652.	0.3	1
134	3-Dimensional Terraced NAND (3D TNAND) Flash Memory-Stacked Version of Folded NAND Array. IEICE Transactions on Electronics, 2009, E92-C, 653-658.	0.3	1
135	Simulation of Retention Characteristics in Double-Gate Structure Multi-Bit SONOS Flash Memory. IEICE Transactions on Electronics, 2009, E92-C, 659-663.	0.3	1
136	Gated Twin-Bit (GTB) nonvolatile memory device and its operation. , 2008, , .		0
137	Vertical channel double split-gate (VCDSG) flash memory. , 2008, , .		0
138	Program efficiency relying on channel conditions at NOR-type flash memory device based on silicon-on-insulator (SOI). , 2008, , .		0
139	Vertical AND (V-AND) array: High density, high speed, and reliable flash array. , 2007, , .		1
140	Simulation study on negative read biasing effects for the reliable operation of NOR type floating gate flash memory devices. , 2007, , .		0
141	Fin flash memory cells with separated double gates. , 2007, , .		0
142	Design and optimization of two-bit double-gate nonvolatile memory cell for highly reliable operation. IEEE Nanotechnology Magazine, 2006, 5, 180-185.	1.1	12
143	Low-pressure, low-temperature hydrogen annealing for nanoscale silicon fin rounding. , 2006, , .		0
144	Depletion-enhanced body-isolation (DEBI) array on SOI for highly scalable and reliable NAND flash memories. IEEE Nanotechnology Magazine, 2006, 5, 201-204.	1.1	4